

Search Notes**Application/Control No.**

10/691,369

Examiner

Quynh H. Nguyen

**Applicant(s)/Patent under
Reexamination**

MAHY ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	202.01	2/6/08	QN
370	260 261	2/6/08	QN
709	204 227	2/6/08	QN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub, USPAT, EPO, JPO	2/6/08	QN
Inventor searched in PALM	2/6/08	QN